## Application/Control No. Applicant(s)/Patent Under Reexamination 09/675,628 CHEN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 X L Bautista 2179 **U.S. PATENT DOCUMENTS** Document Number Date Classification Country Code-Number-Kind Code Name MM-YYYY 715/764 US-5,715,432 02-1998 Xu et al. Α US-В

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